

Top Dilepton Cross Section Measurement Summer 2003 -BLESSING

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on behalf of

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Outline:

- | | |
|------------------|-----------------|
| •Documentation | •Plots to Bless |
| •Q&A | •Results |
| •Event Selection | |

Documentation

- [Q&A web page](#)
- <http://www.cdf.fnal.gov/internal/physics/top/run2dil/summer03/doc.html>
- [Related CDF Notes](#)
 - **CDF6517** “Adding CMIO muons to the top dilepton cross-section”
 - **CDF6579** “Optimization studies for the Top Dilepton Cross-Section Measurement”
 - **CDF6591** “Determination of Drell-Yan backgrounds for the Run II Top Dilepton Cross-Section, summer 2003”
 - **CDF6592** “Fake Lepton Backgrounds for the Summer 2003 Top Dilepton Cross Section”
 - **CDF6590** “Acceptance and Background systematics for the Top Dilepton Cross-Section Measurement”
 - **CDF6588** “A measurement of the $t\bar{t}$ cross-section using dileptons in the central and endplug detectors”
- [Previous talks at this meeting](#)
 - **Chris Hill**, “Dilepton Acceptance”, 06/19/2003
 - **Mircea Coca**, “Dilepton Report”, 07/10/2003
 - **Dave Goldstein**, “Dilepton Cross-Section”, 07/17/2003
 - **Monica Tecchio**, “Preblessing”, 07/24/2003
 - **Andy Hocker**, “Dilepton Cross section Update”, 07/31/2003

Event Selection

- Require two leptons passing ID cuts
 - At least one of which is TIGHT
 - Plug electrons are always isolated
 - At most one central lepton (except CMIO) can be nonisolated
- If leptons are same-species with $76 < M_{ll} < 106$ GeV
 - Require “Jet Significance” > 8.0
 - $\Delta\phi(\text{MET}, \text{closest } j) > 10^\circ$
- Corrected MET > 25 GeV
- $\Delta\phi(\text{closest } l \text{ or } j, \text{MET}) > 20^\circ$ if MET < 50 GeV (“L” cut)
- Two jets with $|\eta| < 2.5$ with corrected $E_T > 15$ GeV
 - Using jet corrections levels 1,2,3,5
- Require corrected $H_T > 200$ GeV
- Require leptons to be opposite signed
 - Does not apply to PEM which do not have tracks

Q&A on Drell-Yan

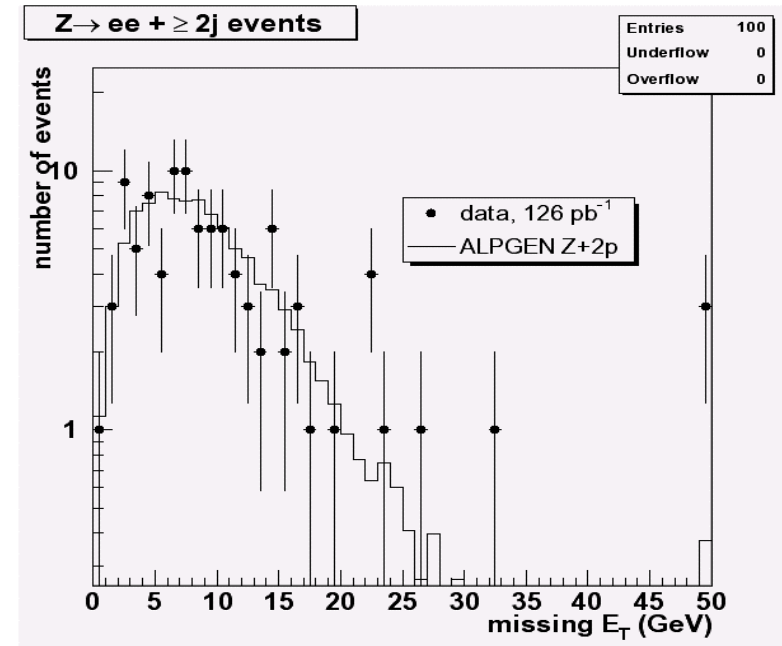
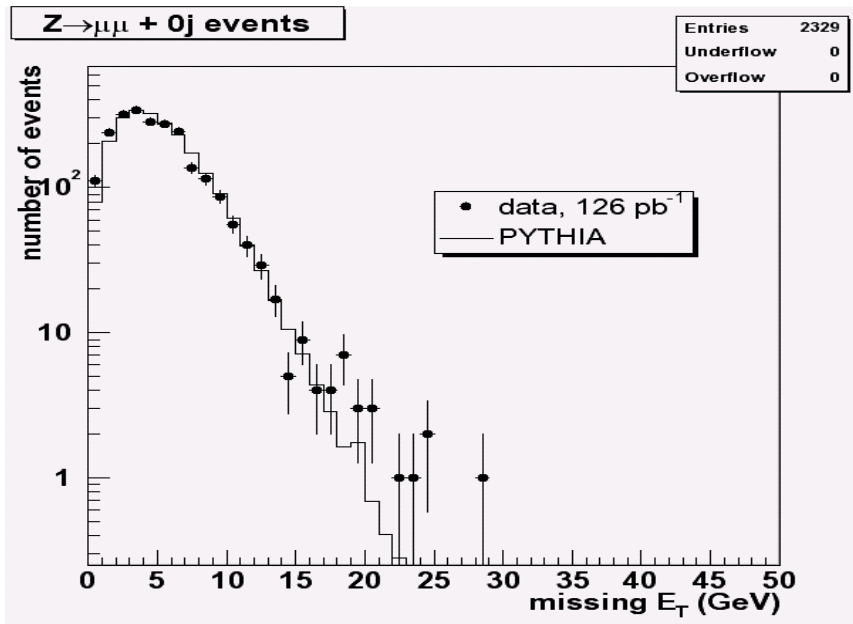
- When determining the “outside” contribution how do you account for MET cut changing the shape of the mass spectrum ?
 - Add new correction factors derived from MC

$$N_{DY}(outside) = (N_Z^p - N_{tt}^Z) \cdot \frac{\mathbf{e}_{MET}^{lo} \cdot \mathbf{e}_{H_T}^{lo} \cdot \mathbf{e}_{2jet}^{lo} \cdot N_{lo} + \mathbf{e}_{MET}^{hi} \cdot \mathbf{e}_{H_T}^{hi} \cdot \mathbf{e}_{2jet}^{hi} \cdot N_{hi}}{\mathbf{e}_{MET}^Z \cdot \mathbf{e}_{H_T}^Z \cdot \mathbf{e}_{2jet}^Z \cdot N_Z}$$

Drell-Yan

- When determining cut efficiencies from the MC for the “inside” contribution how do you correct for the MC underestimating the tails of the MET distribution ?
 - Apply scale factors (Data/MC, $\text{MET} > 25 \text{ GeV}$) to the predicted background (expected $t\bar{t}$, WW subtracted)
 - These scale factors are determined for each jet bin and range from 0.3 to 5.8 with large uncertainties (low data statistics).
 - The average scale factor is 1.2 and a systematic is assigned such that all scale factors are consistent with this number

Drell-Yan Estimate



Channel	0j	1j	≥ 2j	H_T	OS
ee	8.2 ± 3.8	4.14 ± 1.8	1.0 ± 0.6	0.46 ± 0.29	0.46 ± 0.29
$\mu\mu$	1.2 ± 1.2	1.10 ± 1.0	0.74 ± 0.6	0.73 ± 0.56	0.73 ± 0.56
ll	9.4 ± 4.2	5.2 ± 2.3	1.8 ± 0.9	1.2 ± 0.7	1.2 ± 0.7

Estimate in 2 jet bin increase by 0.5 events

Drell-Yan

- **Inside:**
 - We try to use data as much as possible and apply correction factors due the MC poor modelling of the high-met tails
- **Results:**

Channel	0j	1j	$\geq 2j$	H_T	OS
ee	8.2 ± 3.8	4.14 ± 1.8	1.0 ± 0.6	0.46 ± 0.29	0.46 ± 0.29
$\mu\mu$	1.2 ± 1.2	1.10 ± 1.0	0.74 ± 0.6	0.73 ± 0.56	0.73 ± 0.56
ll	9.4 ± 4.2	5.2 ± 2.3	1.8 ± 0.9	1.2 ± 0.7	1.2 ± 0.7

Q&A on fakes

- An updated version of CDF 6592 was posted which addresses the questions
- Why does NICEM fake rate die off at higher E_T ?
 - Iso cut is a ratio, at higher E_T , any electron looks nonisolated
- Why are fakes from CEM are larger than PEM in 2 jet bin?
 - A counting error was found and fixed
- H_T cut efficiency was derived again with a jet threshold of 20 GeV, instead of 15 GeV
 - No effect, still ~50 %
- What is the source of predicted/observed discrepancy in j20 sample ?
 - A mistake found which had to do with the fact that reclustered jets have the isolated electrons removed; now we see better agreement

More on fakes

- How to check the prediction of the fake rates in a statistically independent sample ?
 - Before we used half of j20+j50+j70 to get the fake rates and make predictions in other half of the sample; this was considered “tautological”
 - Now we use jet50 to determine the fake rates and make predictions in jet20, jet70 and jet100
 - Quote half of the largest difference (predicted – observed) as a systematic uncertainty
 - The agreement is better and systematic errors are reduced

Fake predictions-Electrons

Category	Sample	Predicted	Observed
CEM	Jet 100	3 ± 2	6
	Jet 70	18 ± 6	24
	Jet 20	10 ± 4	10
NICEM	Jet 100	12 ± 4	18
	Jet 70	59 ± 9	73
	Jet 20	8 ± 3	5
PHX	Jet 100	19 ± 6	27
	Jet 70	76 ± 13	64
	Jet 20	45 ± 10	32
PEM	Jet 100	61 ± 10	104
	Jet 70	330 ± 26	377
	Jet 20	278 ± 24	236

Fake predictions -Muons

Category	Sample	Predicted	Observed
IMUO	Jet 100	7 ± 4	4
	Jet 70	21 ± 7	11
	Jet 20	10 ± 4	17
NIMUO	Jet 100	2 ± 2	1
	Jet 70	9 ± 4	13
	Jet 20	15 ± 6	16

Systematic uncertainties

Lepton Type	Assigned Systematic Error
CEM	50%
NICEM	25%
PEM	35%
PHX	21%
IMUO	35%
NIMUO	25%

Final Fake Estimate

	0 jet	1 jet	≥ 2 jets	After H_T	After OS
CEM	0.27 ± 0.03	0.17 ± 0.02	0.13 ± 0.01	0.07 ± 0.01	0.03 ± 0.00
NICEM	1.47 ± 0.08	0.93 ± 0.05	0.59 ± 0.03	0.30 ± 0.02	0.15 ± 0.01
PEM	4.33 ± 0.15	3.13 ± 0.15	1.29 ± 0.07	0.65 ± 0.03	0.65 ± 0.03
PHX	0.99 ± 0.07	0.64 ± 0.06	0.25 ± 0.03	0.13 ± 0.01	0.06 ± 0.01
IMUO	0.28 ± 0.03	0.27 ± 0.03	0.14 ± 0.01	0.07 ± 0.01	0.04 ± 0.00
NIMUO	0.24 ± 0.03	0.20 ± 0.02	0.09 ± 0.01	0.05 ± 0.01	0.02 ± 0.00
TOTAL	7.58 ± 0.19	5.35 ± 0.17	2.50 ± 0.08	1.26 ± 0.04	0.95 ± 0.03

Tests of Fake Estimate

- Assume same-sign dilepton events come from fakes
- Compare the #SS events in different jet bins to the expected number from fakes
- PEM do not have sign information – they are excluded from the test

SS events	N = 0 jets	N =1 jets	N =2 jets
Fake Prediction	1.6 ± 1.3	1.1 ± 1.0	$0.6 \pm$
SS Observed	2	3	2
Fake Prediction (no PHX)	1.1 ± 1.0	0.8 ± 0.8	$0.5 \pm$
SS Observed	0	0	0

Acceptance Summary

- As shown before, 5% of the acceptance was coming from l+jets
- To avoid any double-counting we explicitly require in the acceptance calculation HEPG dilepton events
- Without the feed-down contribution of non-isolated categories decreases by only 1 % → most of the non-isolated leptons are from W's

Final Acceptance

- Using Pythia ttopei the raw acceptance is:

$$(0.87 \pm 0.009) \%$$

- Apply the scale factors due to the MC/data id efficiencies and for trigger efficiencies → acceptance decreases by 10 %
- Acceptance has increased from Winter by almost by a factor of 2, while keeping S/B high, S/B = 3.2 : 1

Acceptance breakdown

CDF Run II Preliminary

Dilepton categories	Relative Acceptance (%)	S/B
CC both leptons isolated	69	4.5:1
CC one lepton non-isolated	10	4.4:1
CP/PP both leptons isolated	20	1.5:1
CP one lepton non-isolated	1	3.0:1

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Improvements breakdown

- Increase from Winter 2002 measurement:

CDF Run II Preliminary

Addition	Acceptance increase (%)
Plug electrons	30
Drop isolation 2 nd lep	22
Remove the mass cut	11
Stubless muons	20

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Dilepton Good Run List

- We use the final good run list specified by the top group
- L with minimal requirements = 125.8 pb⁻¹
- Require good CMX = 109 pb⁻¹
- Require good Si, no CMX req = 108 pb⁻¹
- Require good Si and CMX = 96 pb⁻¹
- We use the 12 pb⁻¹ of data reprocess with correct Si alignment → no changes to the observed events

Systematic Uncertainties: Signal Acceptance

CDF Run II Preliminary

Source	Uncertainty (%)
Lepton ID SF + Trig. Effic.	2.0
Jet Corrections	5.6
ISR/FSR	1.6
PDF's	7.7
MC Generators	3.9
Total	10.6

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Systematic Uncertainties: Backgrounds

Background	Source	Uncertainty (%)
Z ? tt	2-jet efficiency	10
	Jet energy scale	32
WW/WZ	MC Generator	40
	Jet energy scale	17
DY (ee, mm)	Method	50
	Jet energy scale	32
Fakes	Method	21-50

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Cross Section Table

Source	Events per 125 pb ⁻¹ after all cuts			
	ee	$\mu\mu$	$e\mu$	$\ell\ell$
WW/WZ	0.14 ± 0.06	0.09 ± 0.04	0.17 ± 0.07	0.40 ± 0.17
Drell-Yan	0.53 ± 0.26	0.28 ± 0.14	-	0.81 ± 0.40
$Z \rightarrow \tau\tau$	0.07 ± 0.02	0.08 ± 0.03	0.17 ± 0.06	0.32 ± 0.11
Fakes	0.31 ± 0.16	0.02 ± 0.01	0.14 ± 0.07	0.53 ± 0.27
Total Background	1.05 ± 0.31	0.37 ± 0.15	0.48 ± 0.12	2.1 ± 0.5
$t\bar{t}$	1.65 ± 0.22	1.40 ± 0.19	3.50 ± 0.47	6.6 ± 0.9
Total SM expectation	2.7 ± 0.4	1.8 ± 0.2	4.0 ± 0.5	8.7 ± 1.0
Run II data	2	4	5	11

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Final Result

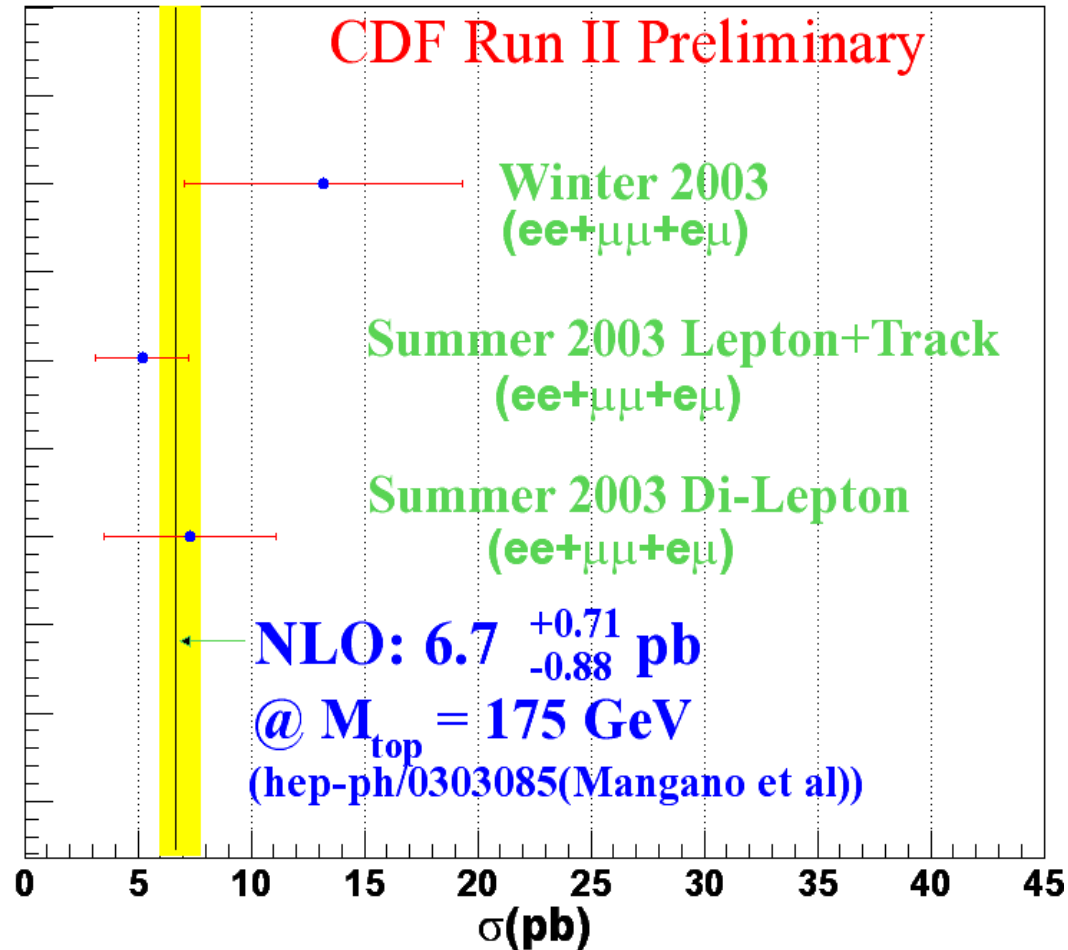
$$\sigma_{tt} = 9.1 \pm 3.4(stat) \pm 1.2(syst) \pm 0.5(lum) pb$$

- Winter result: $13.2 \pm 5.9(stat) \pm 1.5(syst)$
- Theoretical prediction @ 175 GeV, $E_{CM}=1.96$ GeV:
 $\sigma_{tt} = (6.7 \pm 0.5) pb$ (hep-ph/0303085)

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Dilepton Cross Section Run II



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B-tagging Information

- Expected tags:

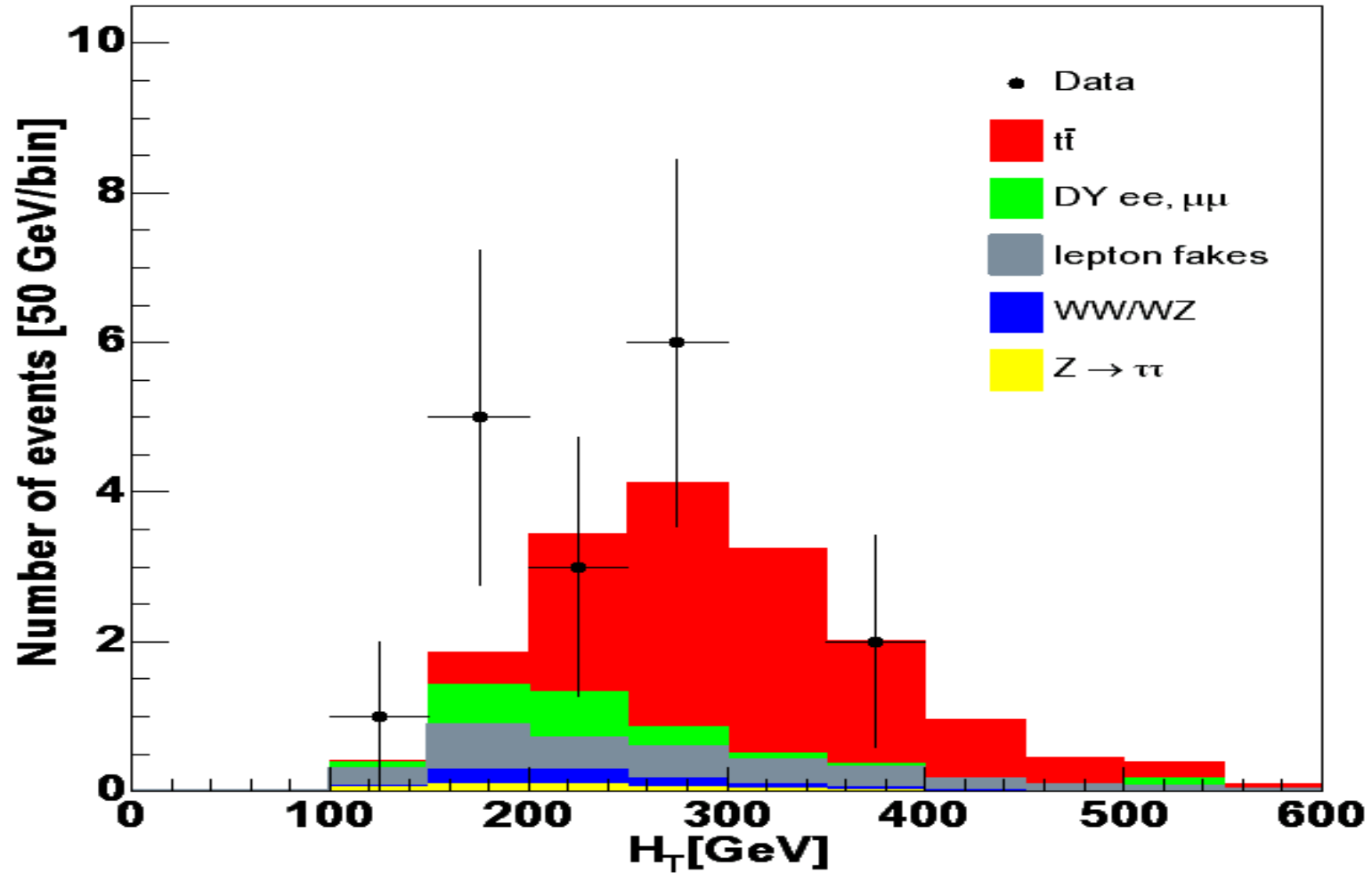
- Tag rate per top event: $(55 \pm 1 \pm 5) \%$
- N_{tagged} (expected) = (3.92 ± 0.24) events
- N_{tagged} (observed) = 6 events

- One double tagged event (CMUP/CMP)

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Kinematic Plots I

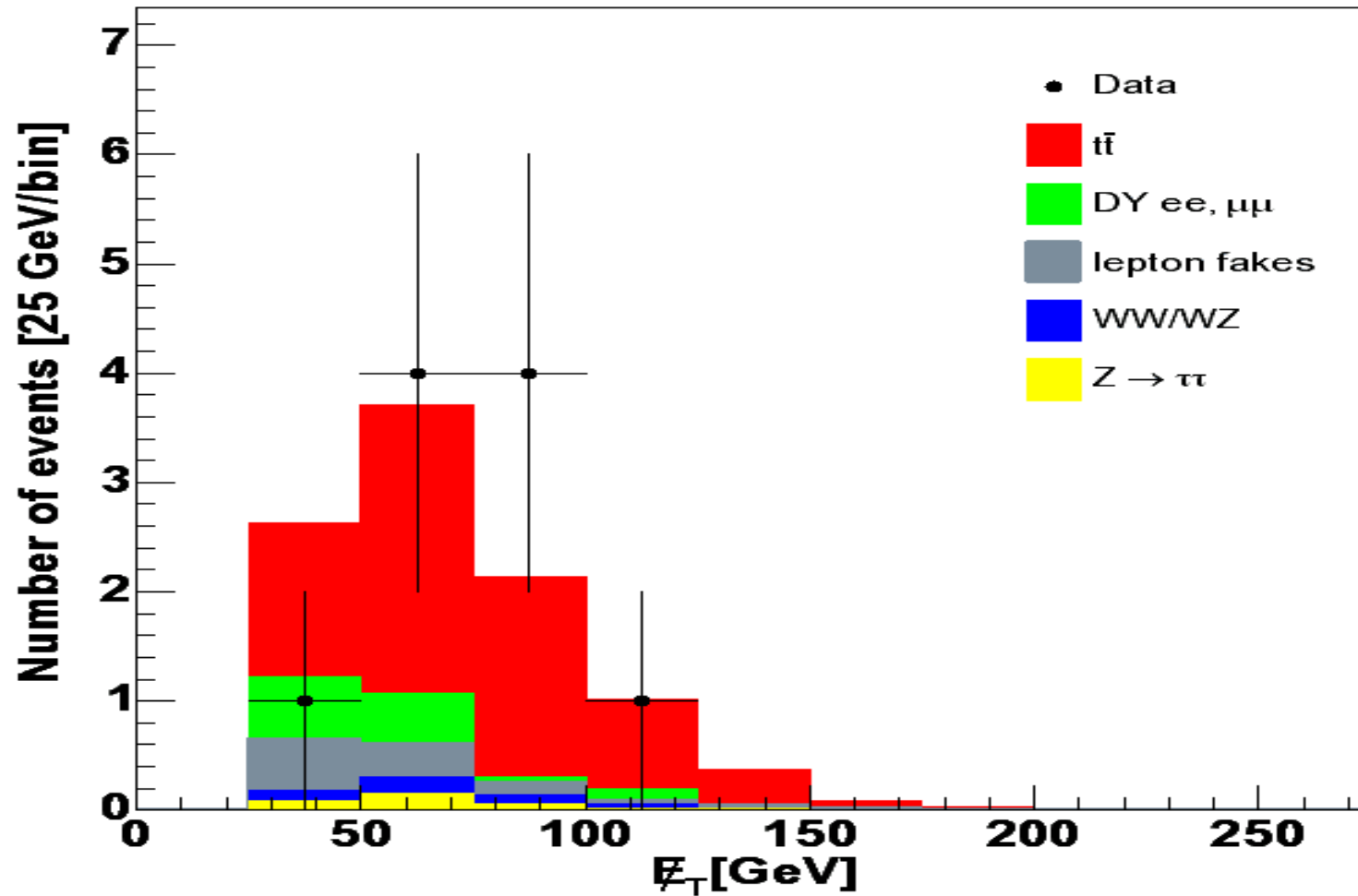
CDF Run II Preliminary $\int L dt = 126 \text{ pb}^{-1}$



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Kinematic Plots II

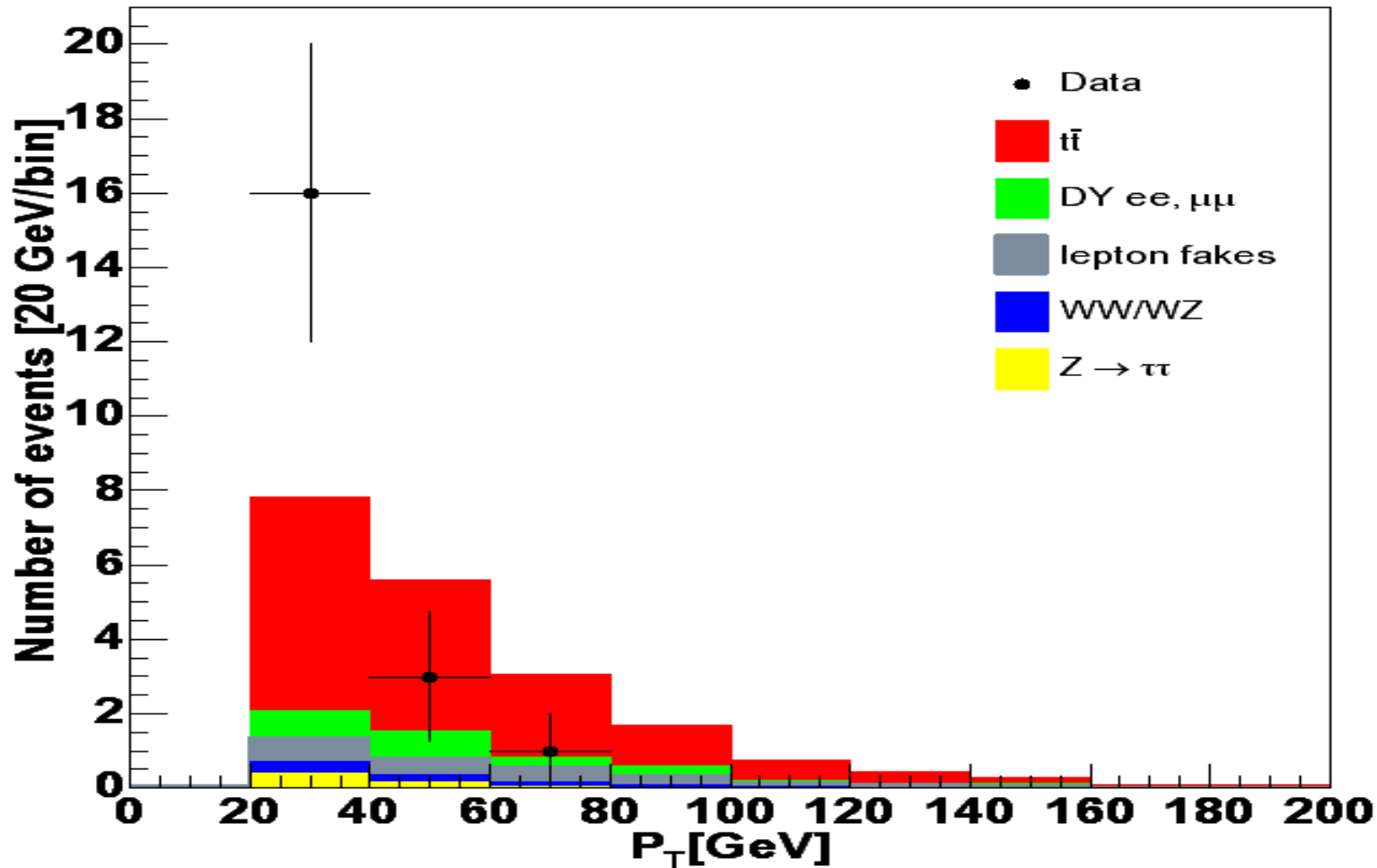
CDF Run II Preliminary $\int L dt = 126 \text{ pb}^{-1}$



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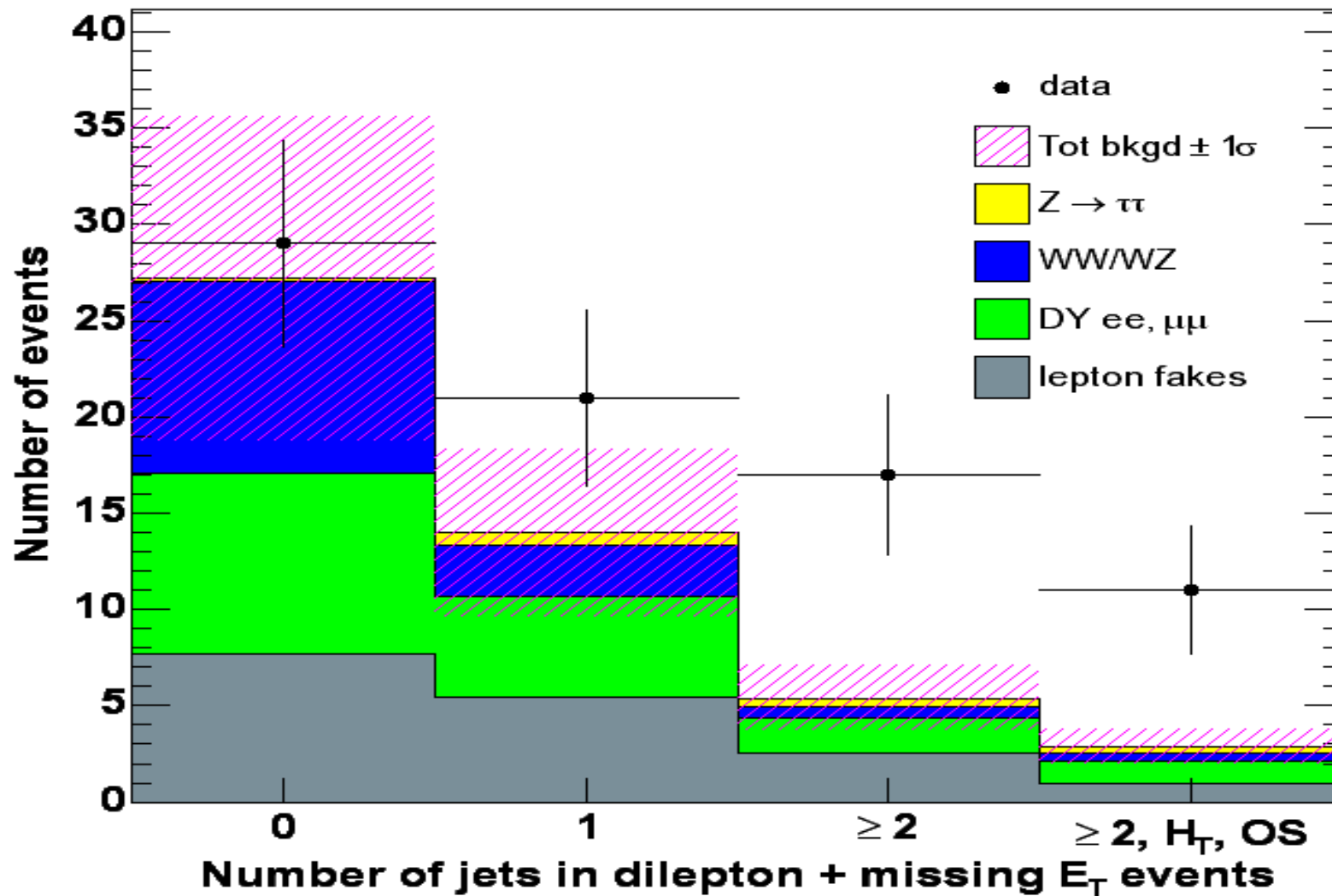
Kinematic Plots III

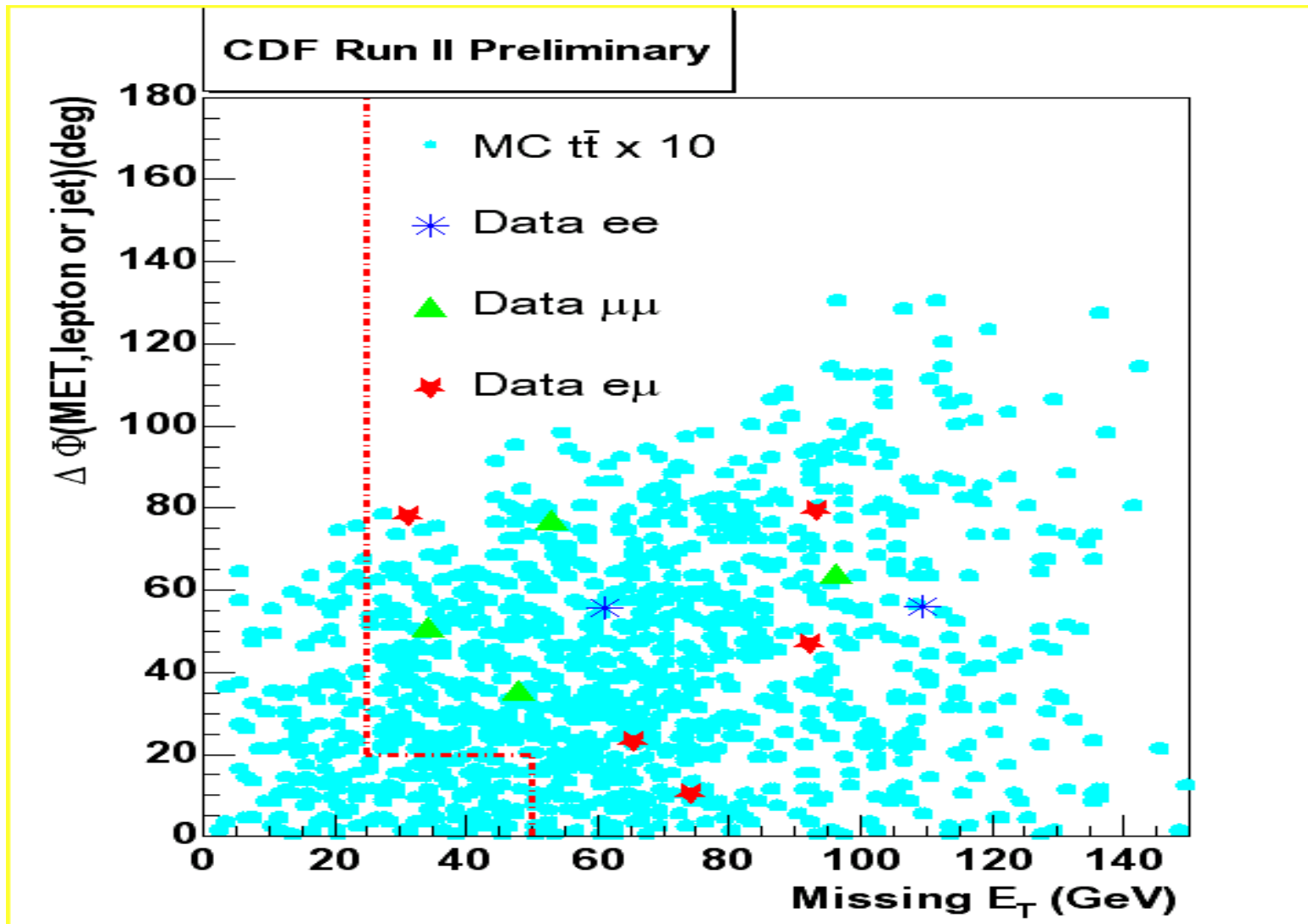
CDF Run II Preliminary $\int L dt = 126 \text{ pb}^{-1}$



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CDF Run II Preliminary $\int L dt = (126 \pm 7.56) \text{ pb}^{-1}$



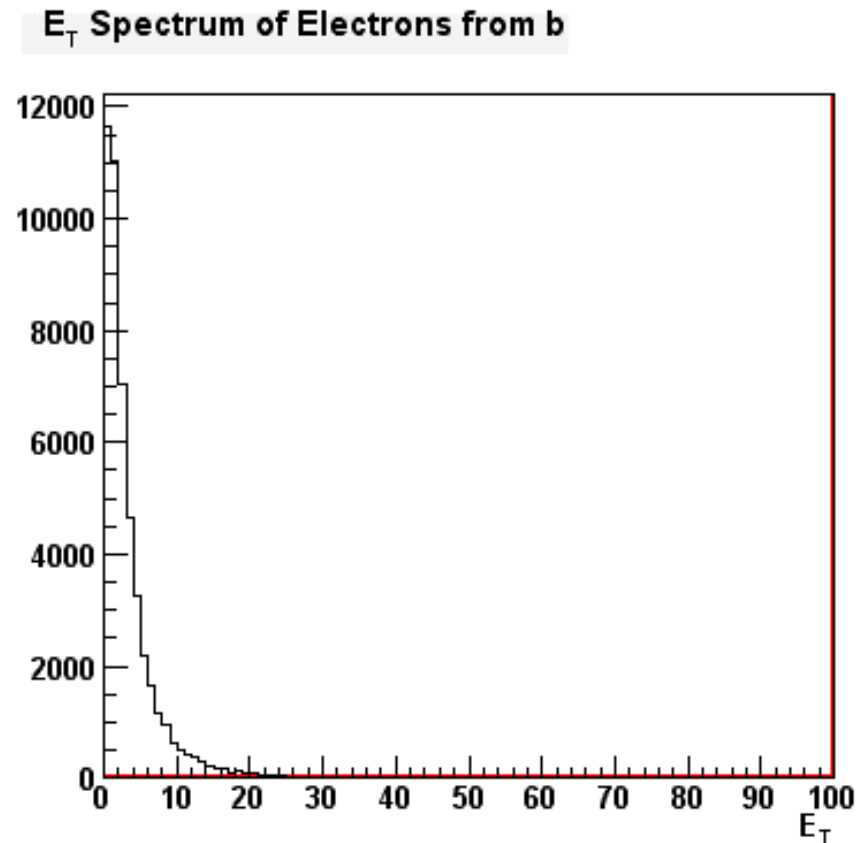


PR Event Displays

Backup Slides

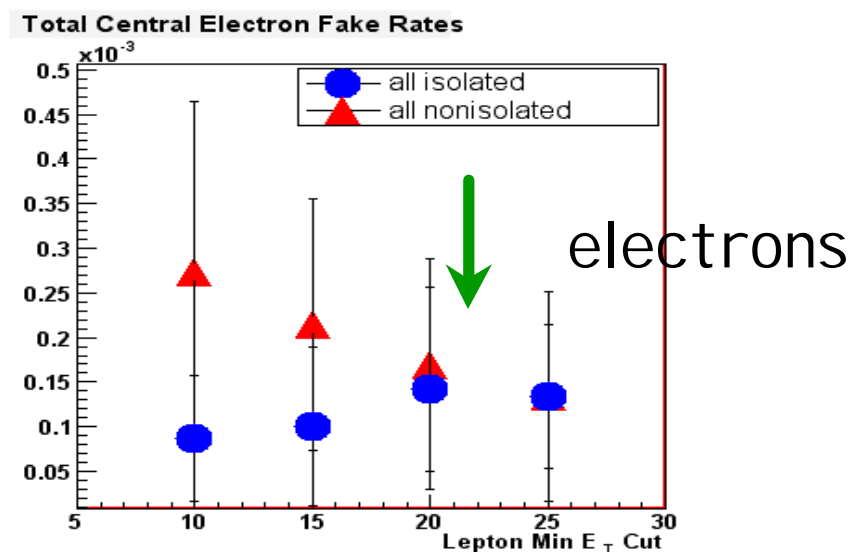
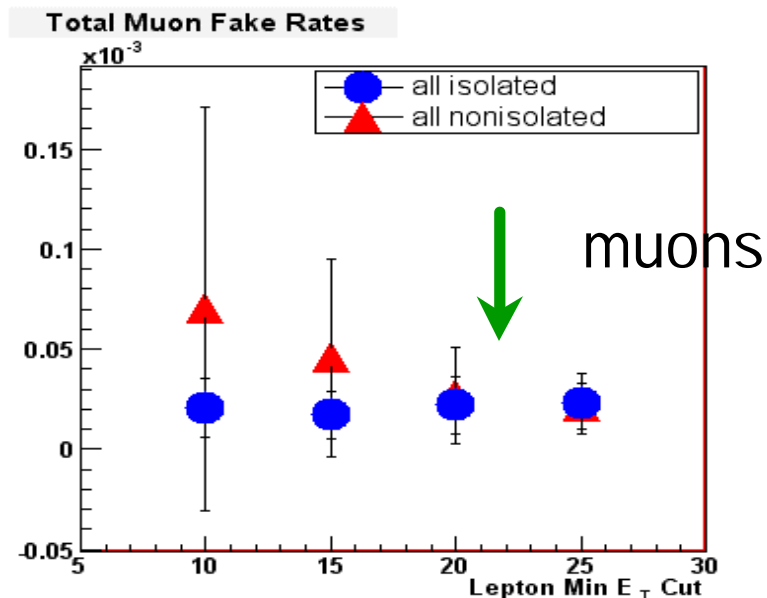
Fakes from b jets (I)

- Believe NI leptons not faked by b's because of E_T cut on electron
 - Not many b's with electrons > 20 GeV
 - E_T spectrum of electrons from b's in Wbb plotted at right
 - This plot is just to give a **qualitative** sense for this contribution
- If this is true, shouldn't we start to see b's if we lower the cut?



Fakes from b jets (II)

- Yes, and we do.
- Non-Isolated fake rates (RED) go up as E_T cut on lepton is lowered,
- At 20 GeV, rates are comparable to isolated lepton fake rates (BLUE).



Fakes from b jets (III)

Measured fake rates using the **8 GeV lepton samples** stripped by the b-tag group

- select events with a SECVTX tag
- measure muon fake rate in electron triggered sample and vice-versa to avoid trigger bias

Lepton Type	Fakes	Number of <i>b</i> -jets (+ tracks)	Fake Rate
NICMUP	1	21,347	4.7×10^{-5}
NICMU	0	21,347	$< 4.7 \times 10^{-5}$
NICMP	1	21,347	4.7×10^{-5}
NICMX	0	21,347	$< 4.7 \times 10^{-5}$
NICMX	0	21,347	$< 4.7 \times 10^{-5}$
NICEM	3	20,528	1.5×10^{-4}

To be compared with
fake rates from
generic jets:

$$\mu: 3 \times 10^{-5}$$

$$e: 2 \times 10^{-4}$$

HF fraction in W+jets to be ~1% ? fake rates for b's would have to increase by a factor of 100 to be comparable to those from light quark jets.

We do not see any evidence that this is the case.

W+heavy flavor MC estimates

- Use the numerous W+HF AlpGen+Herwig samples to estimate background per 100 pb⁻¹.
- In 100 pb⁻¹ : < 0.08 events ?? Can these be wrong by x25??

atop16 W($\mu\nu$)bb0p	0.0022 evts	atop13 W(ev)cc0p	0.0064 evts
atop10 W(ev)bb0p(OLD)	0.0066 evts	atop19 W($\mu\nu$)cc0p	0.0038 evts
atop40 W(ev)bb0p(NEW)	0.0035 evts	atop0w W(ev)c0p	0.007 evts
atop41 W(ev)bb1p	0.0046 evts	atop3w W($\mu\nu$)c0p	< 0.012 evts (0 evts pass all cuts)
atop1w W(ev)c1p	0.0043 evts	atop4w W($\mu\nu$)c1p	0.026 evts

Changes to Event Selection

- Extend jets to $|\eta| < 2.5$
 - Winter analysis used $|\eta| < 2.0$
- Cutting on corrected instead of raw quantities
 - Use Jet Corrections 1,2,3,5
 - Count jets with corrected $E_T > 15$ GeV
 - Winter analysis used raw $E_T > 10$ GeV
 - Use these jets to correct MET and calculate H_T
- As was done in Run I, loose central leptons not required to be isolated
 - Does not apply to CMIOs
- Trilepton category added
- CMX muons no longer vetoed if have CMU/BMU stubs

Acceptance Corrections

- Rescale lepton ID efficiencies to match those observed in Z data; **Scale Factors applied:**
 - CMUP: 0.94 +/- 0.01
 - CMX: 1.00 +/- 0.01
 - CMU: 0.97 +/- 0.02
 - CMP: 0.96 +/- 0.02
 - TCE: 0.98 +/- 0.01
 - NI TCE: 0.78 +/- 0.07
 - PEM: 0.96 +/- 0.05
 - NI MUONS: 0.85 +/- 0.09
- Apply track efficiencies
- Decreases overall acceptance by 6.6%

New Z Veto

- Not so new:
 - CDF 3387 (H. Frisch)
- Exploit the fact that MET from top is real while MET in Z+jets results from jet under-measurement
 - Expect that higher jet ET \rightarrow higher jet fluctuation \rightarrow larger MET.
- Events with MET > 60 GeV \rightarrow jet lost in a crack ($\eta = 0$ or 1.1) \rightarrow use $\Delta\phi(\text{MET}, \text{jet})$ to reject those events

$$jetsig = \frac{MET}{\sqrt{\sum_{|\Delta\phi(met, jet) < 90|} (\vec{E}_T \text{ jet} \cdot \frac{\vec{MET}}{MET})}}$$

MET/ σ_{MET}

Dilepton Categories

- Events are required to have two leptons
 - At least one of which is TIGHT ISOLATED lepton
- Trigger lepton is required to be TIGHT
- Permuting TIGHT with LOOSE
 - **26** dilepton categories
 - ee: 5 categories
 - e μ : 9 categories
 - $\mu\mu$: 12 categories
 - **1** trilepton category

<u>TIGHT</u>	<u>LOOSE</u>
CEM	PEM
CMUP	CMU
CMX	CMP
PHX	CMIO

Data candidates

- 10 candidates:

- ee: 2 events
 - eμ: 5 events
 - μμ: 3 events
- | | | |
|--|------------|--|
| | 1 CEM-CEM | |
| | 1 CEM-PEM | |
| | 2 CEM-CMX | |
| | 1 CEM-CMIO | |
| | 1 CEM-CMU | |
| | 1 CMUP-CMP | |
| | 1 CMUP-CMX | |
| | 1 CMX-CMX | |